

Search Notes**Application/Control No.**

10/611,334

Examiner

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Applicant(s)/Patent under Reexamination

HECK ET AL.

Art Unit

2823

SEARCHED

Class	Subclass	Date	Examiner
438	25,51	3/2/2007	LEE
438	106-108	3/2/2007	LEE
438	113	3/2/2007	LEE
257	414,678	3/2/2007	LEE
257	684,704	3/2/2007	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST attached (USPAT, USPG, USOCR, EPO, JPO, IBM, Derwent)	2/27/2007	LEE
EAST attached (USPAT, USPG)	3/2/2007	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner